

# On Local Distributed Sampling and Counting

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Joint work with Weiming Feng (Nanjing University)

# Counting and Sampling

## RANDOM GENERATION OF COMBINATORIAL STRUCTURES FROM A UNIFORM DISTRIBUTION

Mark R. JERRUM

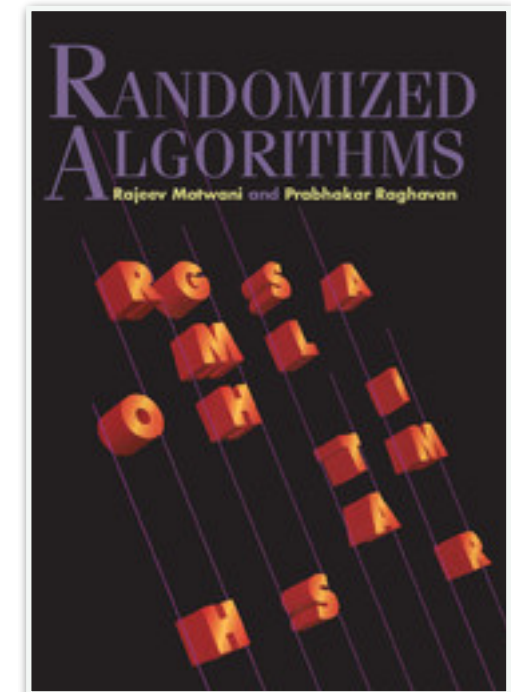
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Vijay V. VAZIRANI \*\*

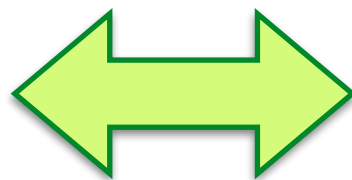
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[Jerrum-Valiant-Vazirani '86]:

(For *self-reducible* problems)

approx. counting  
is tractable



(approx., exact) sampling  
is tractable

# Computational Phase Transition

Sampling **almost-uniform independent set** in graphs with maximum degree  $\Delta$ :

- [Weitz, STOC'06]: If  $\Delta \leq 5$ , poly-time.
- [Sly, **best paper** in FOCS'10]: If  $\Delta \geq 6$ , no poly-time algorithm unless **NP=RP**.

A **phase transition** occurs when  $\Delta: 5 \rightarrow 6$ .

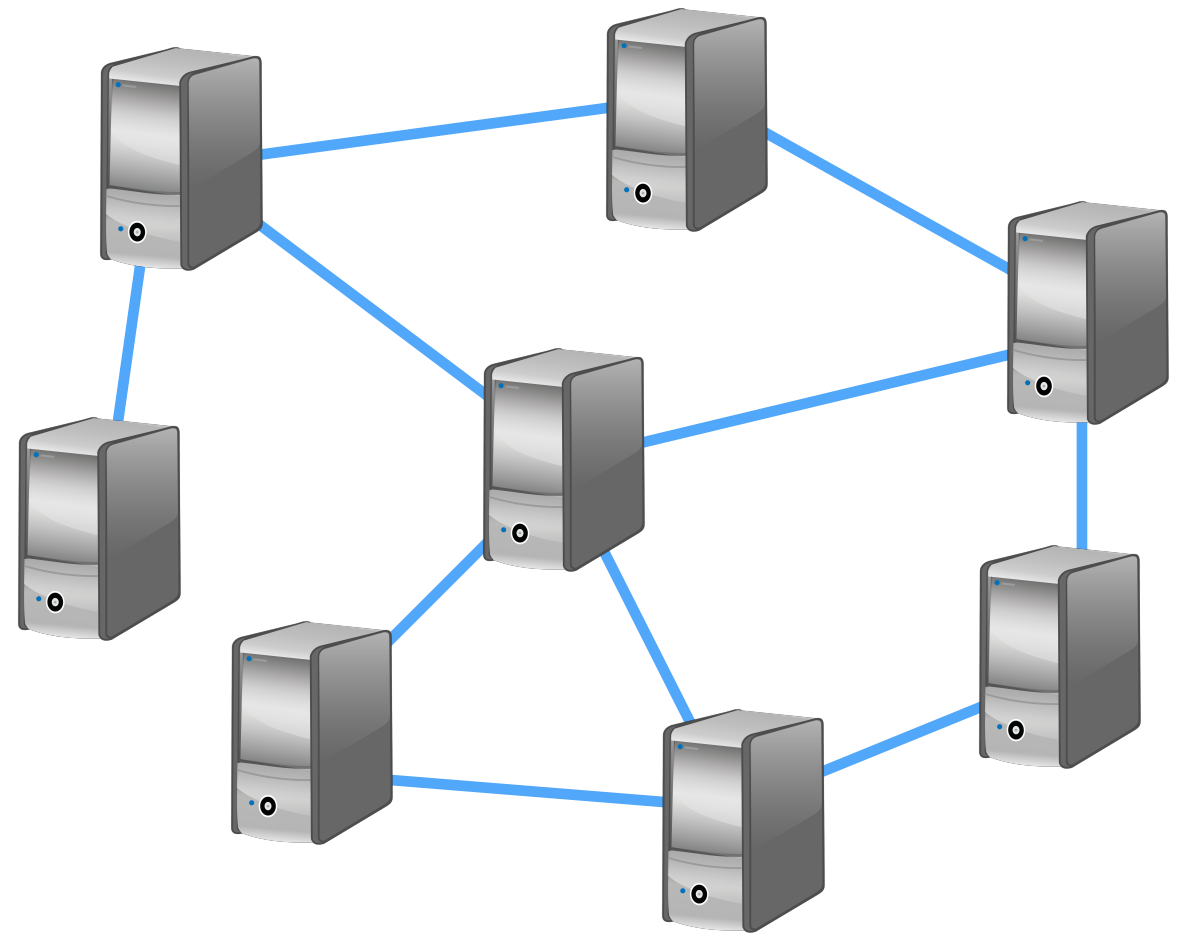
**Local Computation?**

# Local Computation

*“What can be computed locally?”* [Naor, Stockmeyer '93]

the *LOCAL* model [Linial '87]:

- Communications are **synchronized**.
- In each **round**, each node can:
  - exchange **unbounded** messages with all neighbors
  - perform **unbounded** local computation
  - read/write to **unbounded** local memory.



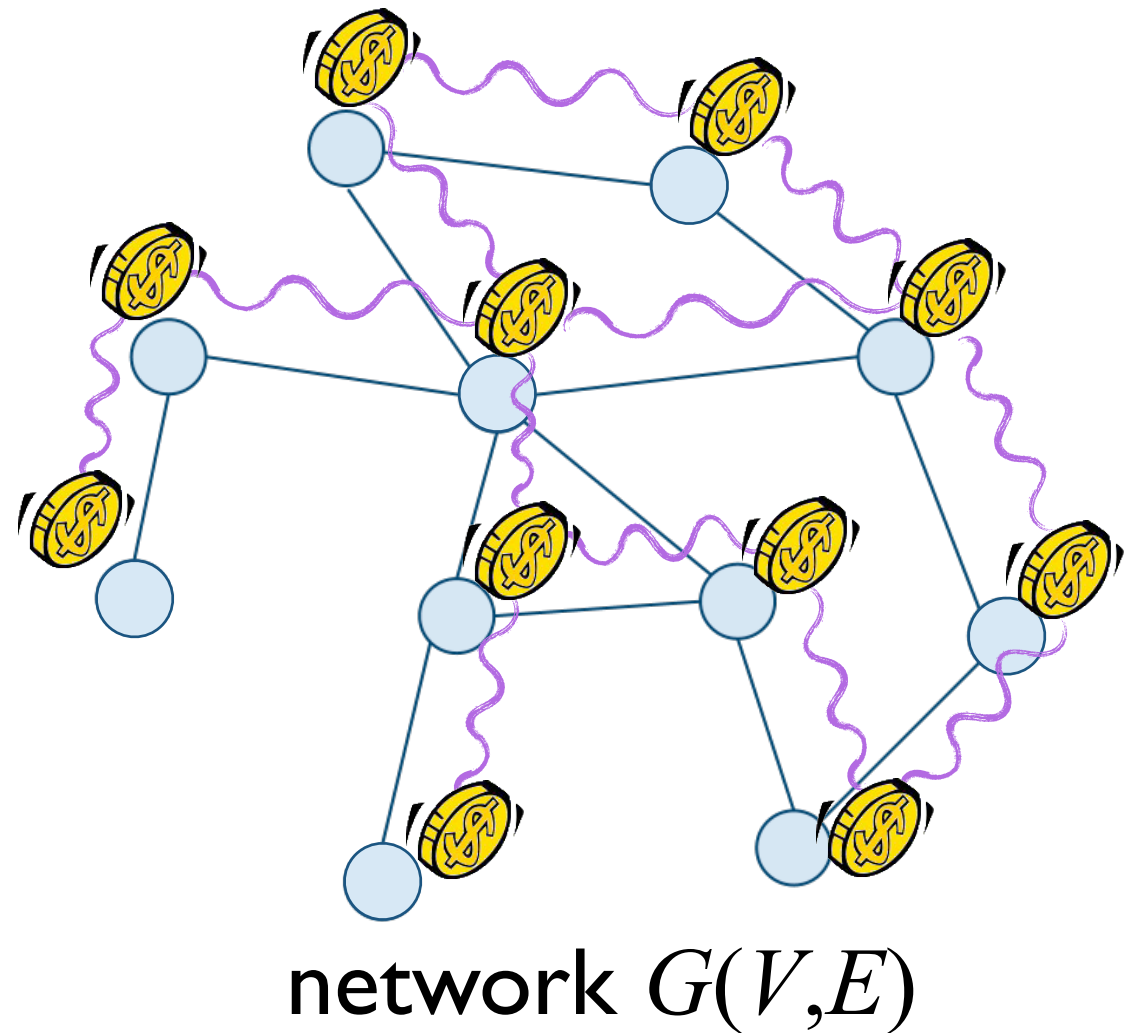
- In  $t$  rounds: each node can collect information up to distance  $t$ .

# Example: Sample Independent Set

$\mu$ : uniform distribution of independent sets in  $G$ .

$Y \in \{0,1\}^V$  indicates an independent set

- Each  $v \in V$  returns a  $Y_v \in \{0,1\}$ , such that  $Y = (Y_v)_{v \in V} \sim \mu$
- Or:  $d_{\text{TV}}(Y, \mu) < 1/\text{poly}(n)$



# Inference (Local Counting)

$\mu$ : **uniform distribution** of **independent sets** in  $G$ .

$\mu_v^\sigma$ : **marginal distribution** at  $v$  conditioning on  $\sigma \in \{0,1\}^S$ .

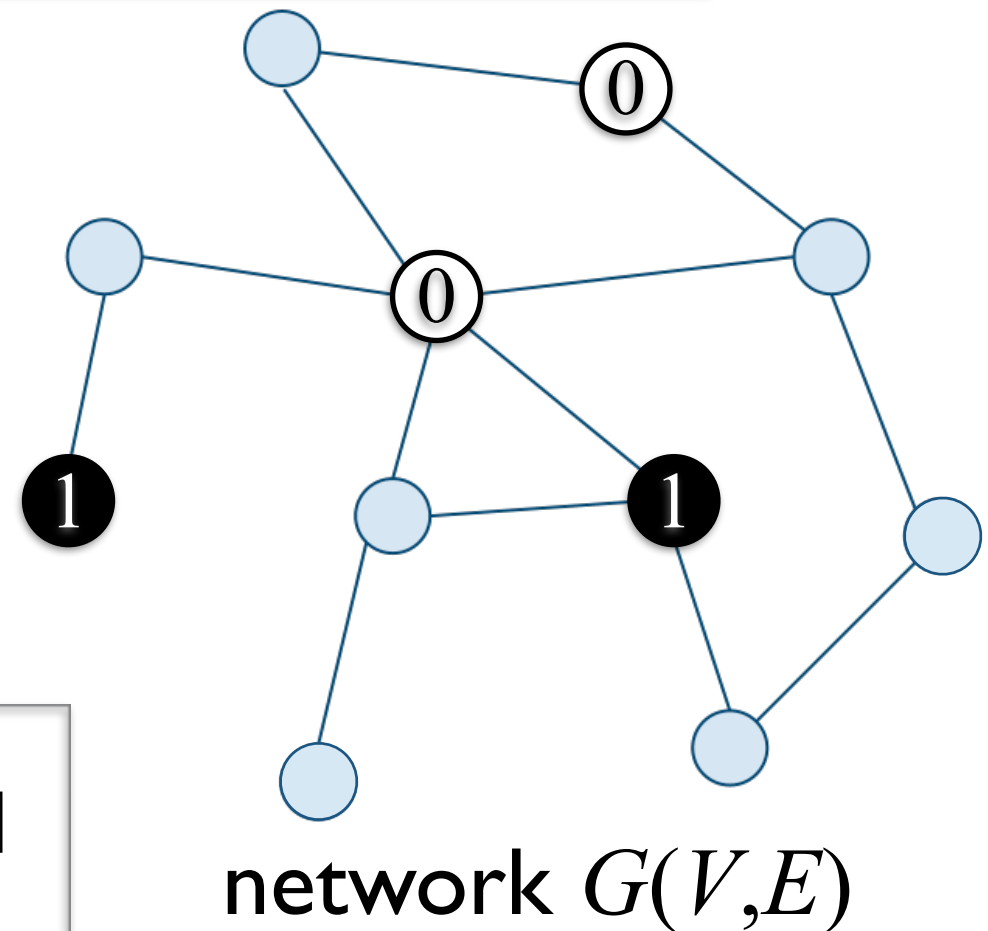
$$\forall y \in \{0,1\} : \mu_v^\sigma(y) = \Pr_{\mathbf{Y} \sim \mu} [Y_v = y \mid Y_S = \sigma]$$

- Each  $v \in S$  receives  $\sigma_v$  as **input**.
- Each  $v \in V$  returns a **marginal distribution**  $\hat{\mu}_v^\sigma$  such that:

$$d_{\text{TV}}(\hat{\mu}_v^\sigma, \mu_v^\sigma) \leq \frac{1}{\text{poly}(n)}$$

$$\frac{1}{Z} = \mu(\emptyset) = \prod_{i=1}^n \Pr_{\mathbf{Y} \sim \mu} [Y_{v_i} = 0 \mid \forall j < i : Y_{v_j} = 0]$$

$Z$ : # of independent sets



# Gibbs Distribution

(with pairwise interactions)

- Each vertex corresponds to a **variable** with finite domain  $[q]$ .
- Each edge  $e=(u,v)\in E$  has a matrix (**binary constraint**):

$$A_e: [q] \times [q] \rightarrow [0,1]$$

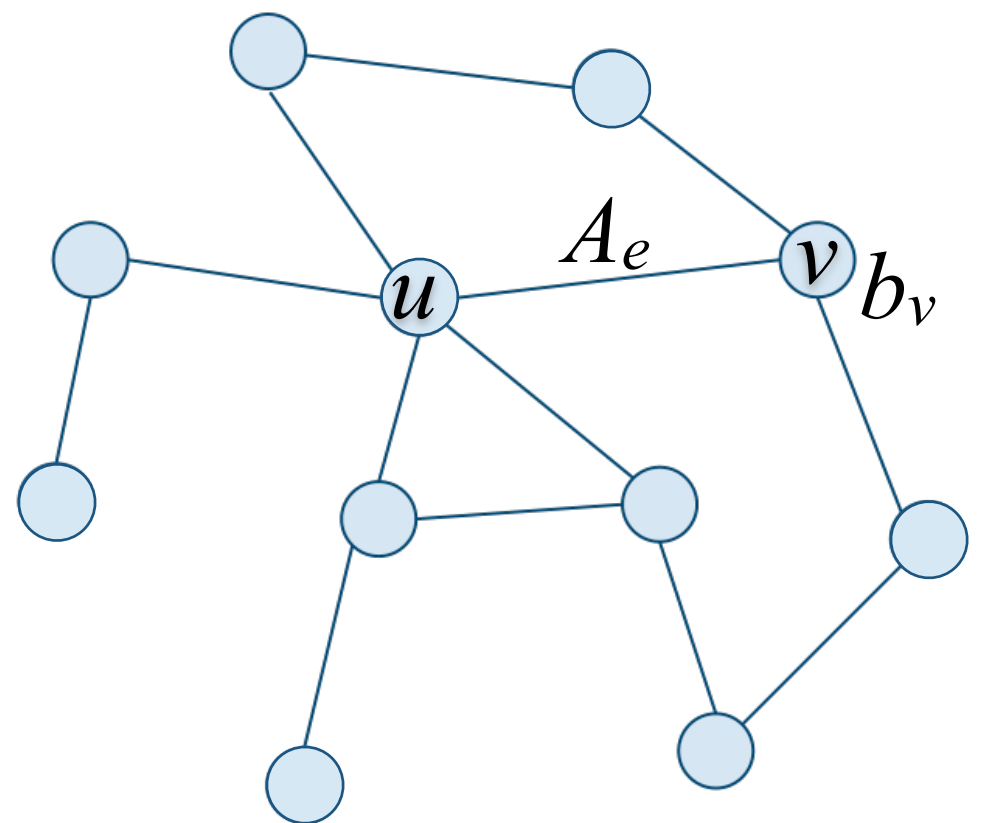
- Each vertex  $v\in V$  has a vector (**unary constraint**):

$$b_v: [q] \rightarrow [0,1]$$

- **Gibbs distribution**  $\mu: \forall \sigma \in [q]^V$

$$\mu(\sigma) \propto \prod_{e=(u,v)\in E} A_e(\sigma_u, \sigma_v) \prod_{v\in V} b_v(\sigma_v)$$

network  $G(V,E)$ :



# Gibbs Distribution

(with pairwise interactions)

- **Gibbs distribution**  $\mu : \forall \sigma \in [q]^V$

$$\mu(\sigma) \propto \prod_{e=(u,v) \in E} A_e(\sigma_u, \sigma_v) \prod_{v \in V} b_v(\sigma_v)$$

- **independent set:**

$$A_e = \begin{bmatrix} 1 & 1 \\ 1 & 0 \end{bmatrix} \quad b_v = \begin{bmatrix} 1 \\ 1 \end{bmatrix}$$

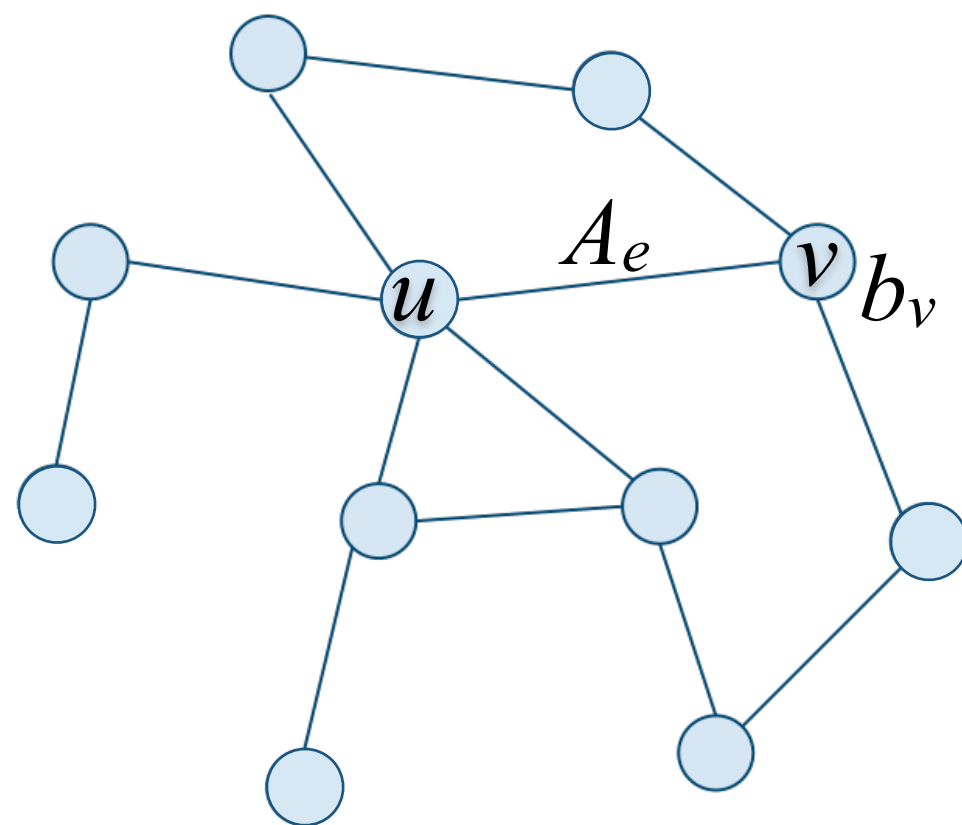
- **local conflict colorings:**

[Fraigniaud, Heinrich, Kosowski, FOCS'16]

$$A_e: [q] \times [q] \rightarrow \{0,1\}$$

$$b_v: [q] \rightarrow \{0,1\}$$

network  $G(V,E)$ :



$$A_e: [q] \times [q] \rightarrow [0,1]$$

$$b_v: [q] \rightarrow [0,1]$$



# Gibbs Distribution

- Gibbs distribution  $\mu : \forall \sigma \in [q]^V$

$$\mu(\sigma) \propto \prod_{(f,S) \in \mathcal{F}} f(\sigma_S)$$

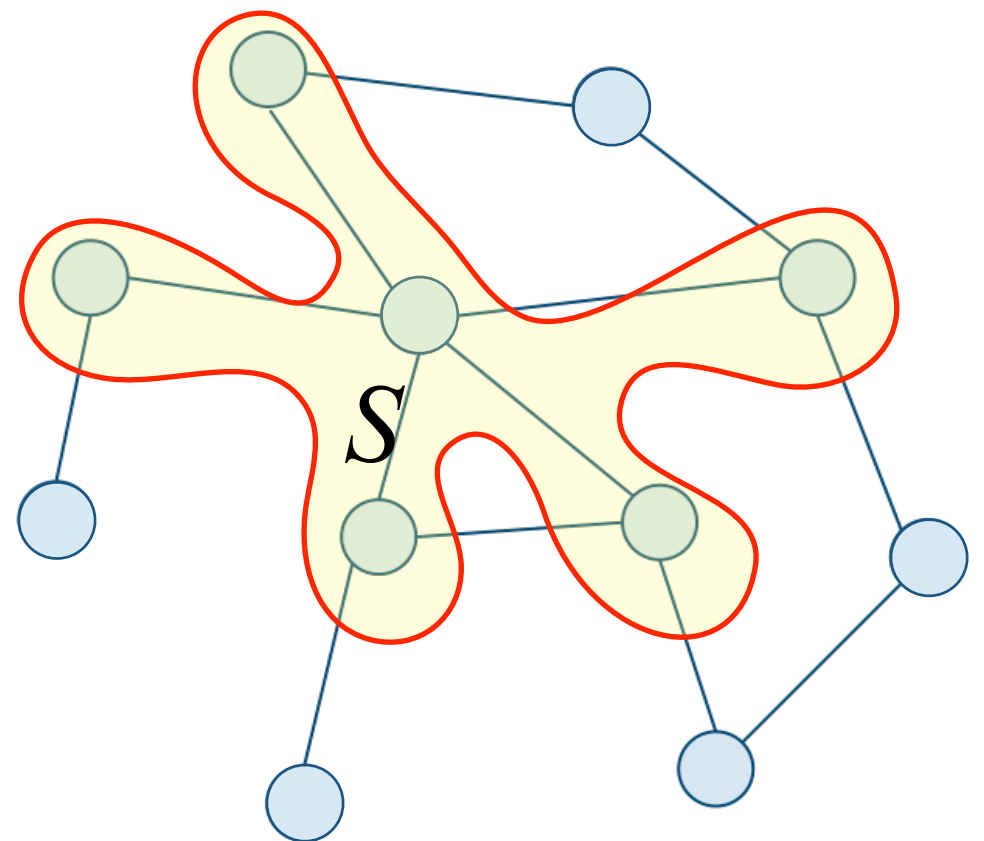
each  $(f, S) \in \mathcal{F}$

is a *local constraints* (factors):

$$f : [q]^S \rightarrow \mathbb{R}_{\geq 0}$$

$$S \subseteq V \text{ with } \text{diam}_G(S) = O(1)$$

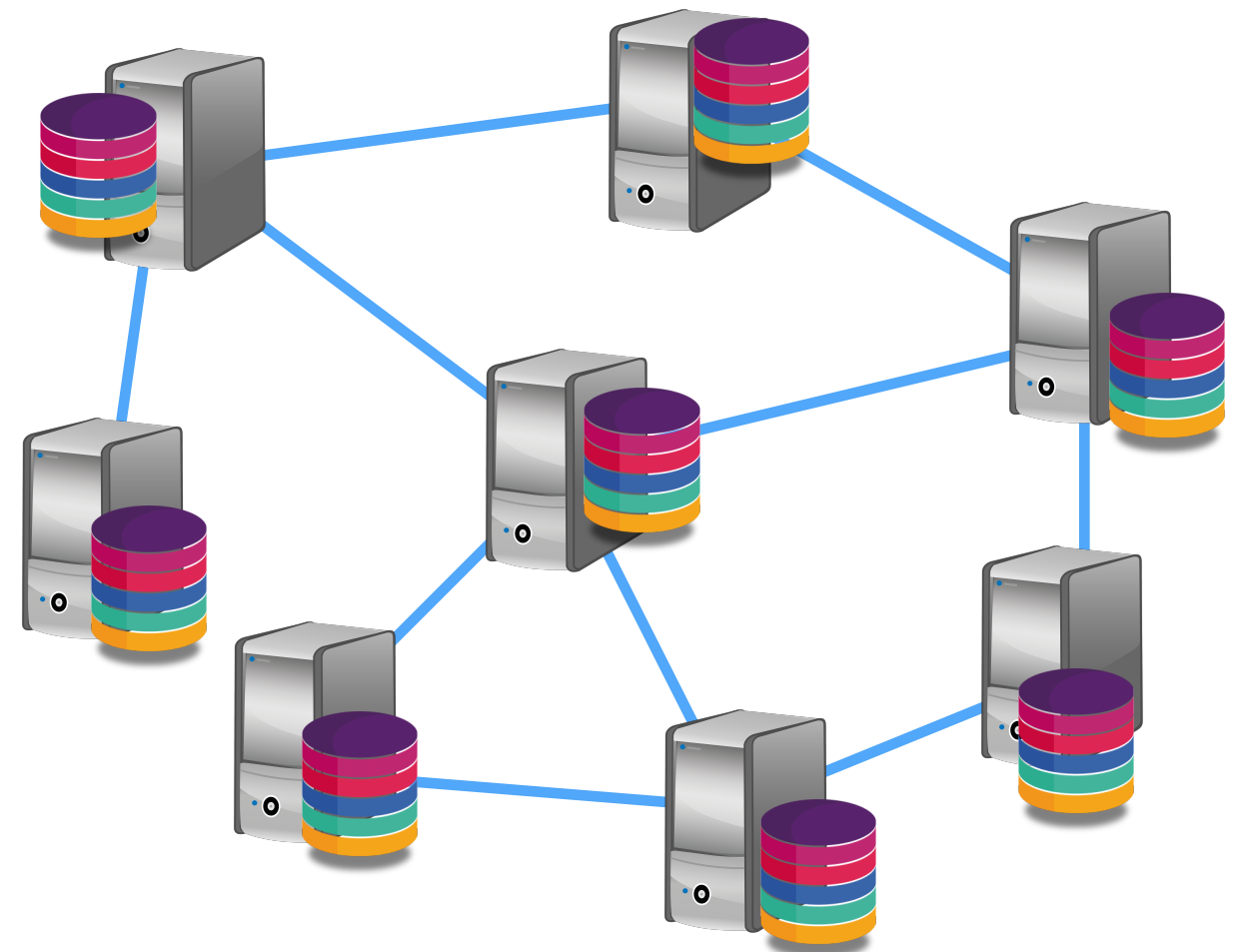
network  $G(V, E)$ :



# A Motivation:

## *Distributed Machine Learning*

- Data are stored in a distributed system.
- Distributed algorithms for:
  - sampling from a *joint distribution* (specified by a *probabilistic graphical model*);
  - inferring according to a *probabilistic graphical model*.



# Computational Phase Transition

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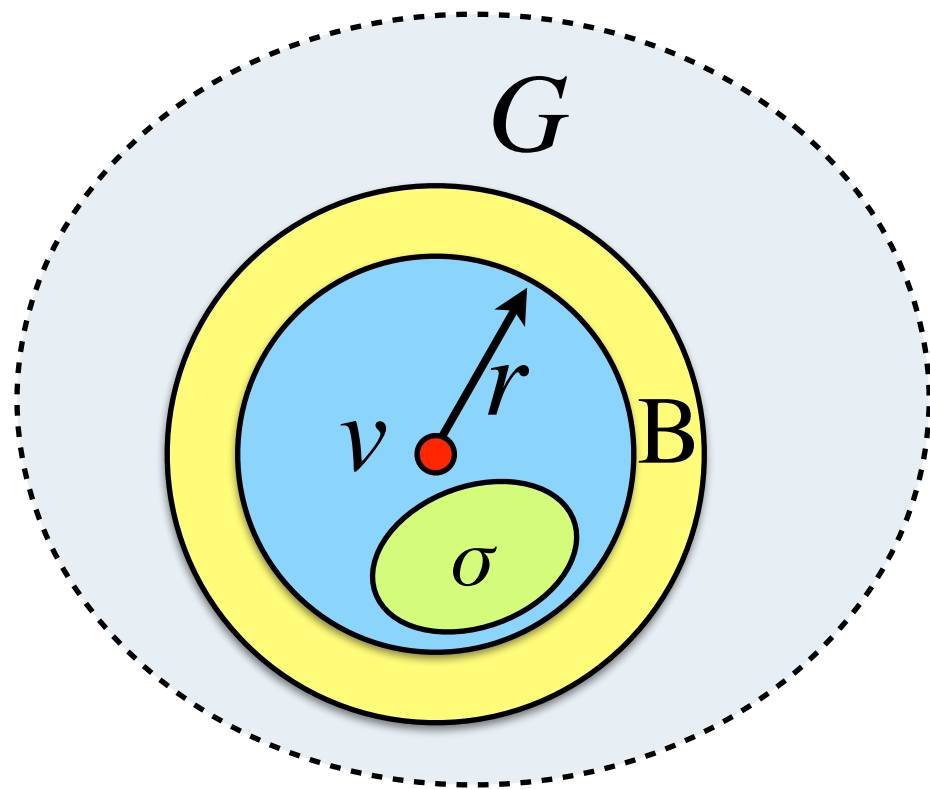
# Decay of Correlation

$\mu_v^\sigma$ : **marginal distribution** at  $v$  conditioning on  $\sigma \in \{0,1\}^S$ .

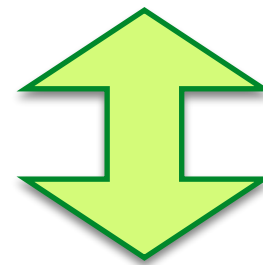
**strong spatial mixing (SSM)**:

$\forall$  boundary condition  $B \in \{0,1\}^{r\text{-sphere}(v)}$ :

$$d_{\text{TV}}(\mu_v^\sigma, \mu_v^{\sigma, B}) \leq \text{poly}(n) \cdot \exp(-\Omega(r))$$



**SSM** (iff  $\Delta \leq 5$  when  $\mu$  is uniform distribution of ind. sets)



**approx. inference** is solvable  
in  $O(\log n)$  rounds  
in the **LOCAL** model

# Locality of Counting & Sampling

For **Gibbs distributions** (defined by *local factors*):

Correlation  
Decay:

SSM

Inference:

local approx.  
inference

with **additive** error



local approx.  
inference

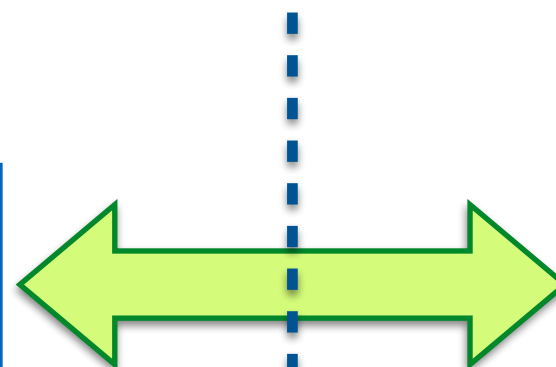
with **multiplicative** error

Sampling:

local approx.  
sampling

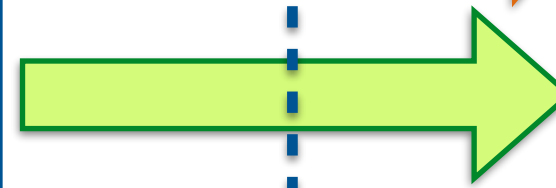


local **exact**  
sampling



easy

$O(\log^2 n)$  factor



# Locality of Sampling

Correlation  
Decay:

SSM

Inference:

local approx.  
inference

Sampling:

local approx.  
sampling

each  $v$  can compute a  $\hat{\mu}_v^\sigma$   
within  $O(\log n)$ -ball

$$\text{s.t. } d_{\text{TV}}(\hat{\mu}_v^\sigma, \mu_v^\sigma) \leq \frac{1}{\text{poly}(n)}$$

return a random  $Y = (Y_v)_{v \in V}$   
whose distribution  $\hat{\mu} \approx \mu$

$$d_{\text{TV}}(\hat{\mu}, \mu) \leq \frac{1}{\text{poly}(n)}$$

**sequential**  $O(\log n)$ -**local** procedure:

- scan vertices in  $V$  in an arbitrary order  $v_1, v_2, \dots, v_n$
- for  $i=1, 2, \dots, n$ : sample  $Y_{v_i}$  according to  $\hat{\mu}_{v_i}^{Y_{v_1}, \dots, Y_{v_{i-1}}}$



# Network Decomposition

$(C,D)$ -**network-decomposition** of  $G$ :

- classifies vertices into clusters;
- assign each cluster a color in  $[C]$ ;
- each cluster has diameter  $\leq D$ ;
- clusters are properly colored.

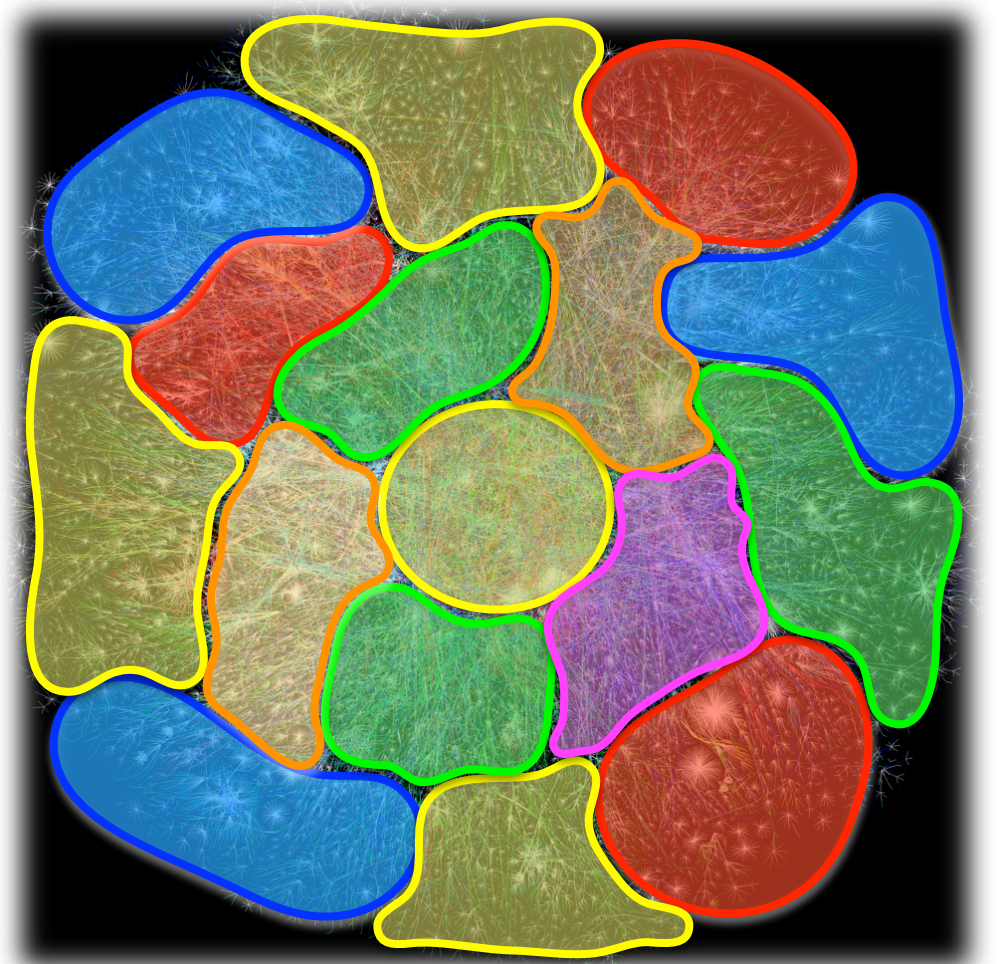
$(C,D)^r$ -**ND**:  $(C,D)$ -**ND** of  $G^r$

Given a  $(C,D)^r$ - **ND**:

**sequential**  $r$ -**local** procedure:  $r = O(\log n)$

- scan vertices in  $V$  in an arbitrary order  $v_1, v_2, \dots, v_n$
- for  $i=1,2, \dots, n$ : sample  $Y_{v_i}$  according to  $\hat{\mu}_{v_i}^{Y_{v_1}, \dots, Y_{v_{i-1}}}$

can be simulated in  $O(CDr)$  rounds in **LOCAL** model



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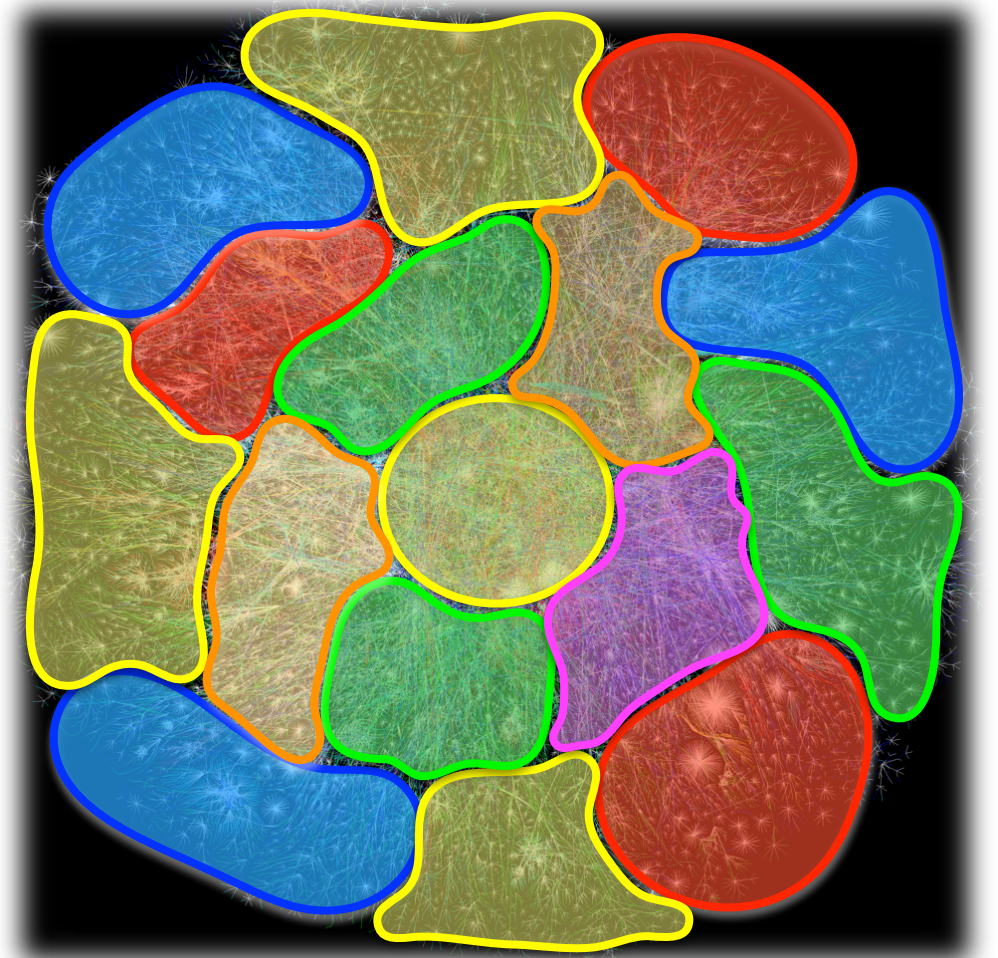
$(O(\log n), O(\log n))^r$ -**ND** can be constructed in  $O(r \log^2 n)$  rounds *w.h.p.*

[Linial, Saks, 1993] — [Ghaffari, Kuhn, Maus, 2017]:

$r$ -local **SLOCAL** algorithm:  
 $\forall$  ordering  $\pi = (v_1, v_2, \dots, v_n)$ ,  
returns random vector  $Y^{(\pi)}$



$O(r \log^2 n)$ -round **LOCAL** alg.:  
returns *w.h.p.* the  $Y^{(\pi)}$   
for some ordering  $\pi$





# Locality of Sampling

Correlation  
Decay:

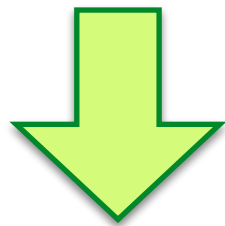
SSM

Inference:

$O(\log n)$ -round

local approx.  
inference

with additive error



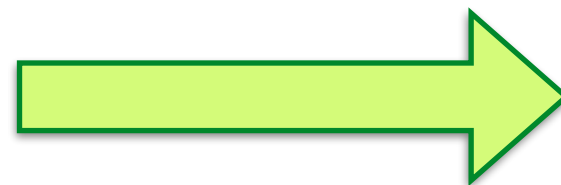
local approx.  
inference

with multiplicative error

Sampling:

$O(\log^3 n)$ -round

local approx.  
sampling



local *exact*  
sampling

# Local Exact Sampler

In  $\mathcal{LOCAL}$  model:

- Each  $v \in V$  returns within **fixed**  $t(n)$  rounds:
  - **local output**  $Y_v \in \{0,1\}$ ;
  - **local failure**  $F_v \in \{0,1\}$ .
- **Succeeds w.h.p.:**  $\sum_{v \in V} \mathbf{E}[F_v] = O(1/n)$ .
- **Correctness:** conditioning on success,  $Y \sim \mu$ .

# Jerrum-Valiant-Vazirani Sampler

[Jerrum-Valiant-Vazirani '86]

$\exists$  an efficient algorithm that samples from  $\hat{\mu}$   
and evaluates  $\hat{\mu}(\sigma)$  given any  $\sigma \in \{0, 1\}^V$

**multiplicative error:**  $\forall \sigma \in \{0, 1\}^V : e^{-1/n^2} \leq \frac{\hat{\mu}(\sigma)}{\mu(\sigma)} \leq e^{1/n^2}$

Self-reduction:

$$\mu(\sigma) = \prod_{i=1}^n \mu_{v_i}^{\sigma_1, \dots, \sigma_{i-1}}(\sigma_i) = \prod_{i=1}^n \frac{Z(\sigma_1, \dots, \sigma_i)}{Z(\sigma_1, \dots, \sigma_{i-1})}$$

$$\text{let } \hat{\mu}_{v_i}^{\sigma_1, \dots, \sigma_{i-1}}(\sigma_i) = \frac{\hat{Z}(\sigma_1, \dots, \sigma_i)}{\hat{Z}(\sigma_1, \dots, \sigma_{i-1})} \approx e^{\pm 1/n^3} \cdot \mu_{v_i}^{\sigma_1, \dots, \sigma_{i-1}}(\sigma_i)$$

where  $e^{-1/2n^3} \leq \frac{\hat{Z}(\dots)}{Z(\dots)} \leq e^{1/2n^3}$  by approx. counting

# Jerrum-Valiant-Vazirani Sampler

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**multiplicative error:**  $\forall \sigma \in \{0, 1\}^V : e^{-1/n^2} \leq \frac{\hat{\mu}(\sigma)}{\mu(\sigma)} \leq e^{1/n^2}$

Sample a random  $Y \sim \hat{\mu}$  ;

pick  $Y_0 = \emptyset$  ;

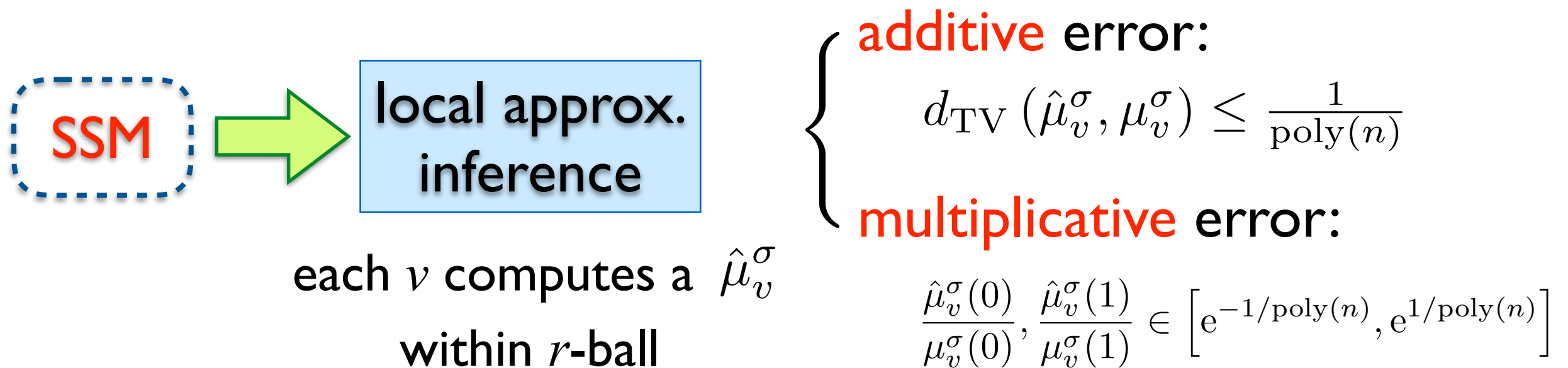
**accept**  $Y$  with prob.:  $q = \frac{\hat{\mu}(Y_0)}{\hat{\mu}(Y)} \cdot e^{-\frac{3}{n^2}} \in \left[ e^{-5/n^2}, 1 \right]$

**fail** if otherwise;

$\forall \sigma \in \{0, 1\}^V :$

$$\Pr[Y = \sigma \wedge \text{accept}] = \hat{\mu}(\sigma) \cdot \frac{\hat{\mu}(\emptyset)}{\hat{\mu}(\sigma)} \cdot e^{-\frac{3}{n^2}} \propto \begin{cases} 1 & \sigma \text{ is ind. set} \\ 0 & \text{otherwise} \end{cases}$$

# Boosting Local Inference



SSM  $\xrightarrow{\text{local self-reduction}}$  both are achievable with  $r = O(\log n)$

*boosted sequential*  $r$ -local sampler:  $r = O(\log n)$

- scan vertices in  $V$  in an arbitrary order  $v_1, v_2, \dots, v_n$
- for  $i=1, 2, \dots, n$ : sample  $Y_{v_i}$  according to  $\hat{\mu}_{v_i}^{Y_{v_1}, \dots, Y_{v_{i-1}}}$

multiplicative error:  $\forall \sigma \in \{0, 1\}^V : e^{-1/n^2} \leq \frac{\hat{\mu}(\sigma)}{\mu(\sigma)} \leq e^{1/n^2}$

# SLOCAL JW

Scan vertices in  $V$  in an arbitrary order  $v_1, v_2, \dots, v_n$ :

**pass 1:** sample  $Y \in \{0,1\}^V$  by *boosted sequential  $r$ -local sampler*  $\hat{\mu}$ ;

$$\forall \sigma \in [q]^V : e^{-1/n^2} \leq \frac{\hat{\mu}(\sigma)}{\mu(\sigma)} \leq e^{1/n^2}$$

$$r = O(\log n)$$

**pass 1':** construct a sequence of ind. sets  $\emptyset = Y_0, Y_1, \dots, Y_n = Y$ ;

s.t.  $\forall 0 \leq i \leq n$ : •  $Y_i$  agrees with  $Y$  over  $v_1, \dots, v_i$

•  $Y_i$  and  $Y_{i-1}$  differ only at  $v_i$

$v_i$  samples  $F_{v_i} \in \{0, 1\}$  independently with  $\Pr[F_{v_i} = 0] = q_{v_i}$

where  $q_{v_i} = \frac{\hat{\mu}(\mathbf{Y}_{i-1})}{\hat{\mu}(\mathbf{Y}_i)} \cdot e^{-3/n^2} \in [e^{-5/n^2}, 1]$

Each  $v \in V$  returns:

- $Y_v \in \{0,1\}$  to indicate the ind. set;
- $F_v \in \{0,1\}$  indicate failure at  $v$ .

$O(\log n)$ -local  
to compute

Scan vertices in  $V$  in an arbitrary order  $v_1, v_2, \dots, v_n$ :

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$$\text{where } q_{v_i} = \frac{\hat{\mu}(\mathbf{Y}_{i-1})}{\hat{\mu}(\mathbf{Y}_i)} \cdot e^{-3/n^2} \in [e^{-5/n^2}, 1]$$

$$\forall \sigma \in \{0, 1\}^V :$$

$$\Pr[\mathbf{Y} = \sigma \wedge \forall i : F_{v_i} = 0] = \hat{\mu}(\sigma) \prod_{i=1}^n q_{v_i} = \hat{\mu}(\sigma) \prod_{i=1}^n \left( \frac{\hat{\mu}(\mathbf{Y}_{i-1})}{\hat{\mu}(\mathbf{Y}_i)} \cdot e^{-3/n^2} \right) \Big|_{\mathbf{Y}_n = \mathbf{Y} = \sigma}$$

$$= \hat{\mu}(\sigma) \cdot \frac{\hat{\mu}(\emptyset)}{\hat{\mu}(\sigma)} \cdot e^{-\frac{3}{n}} \propto \begin{cases} 1 & \sigma \text{ is ind. set} \\ 0 & \text{otherwise} \end{cases}$$



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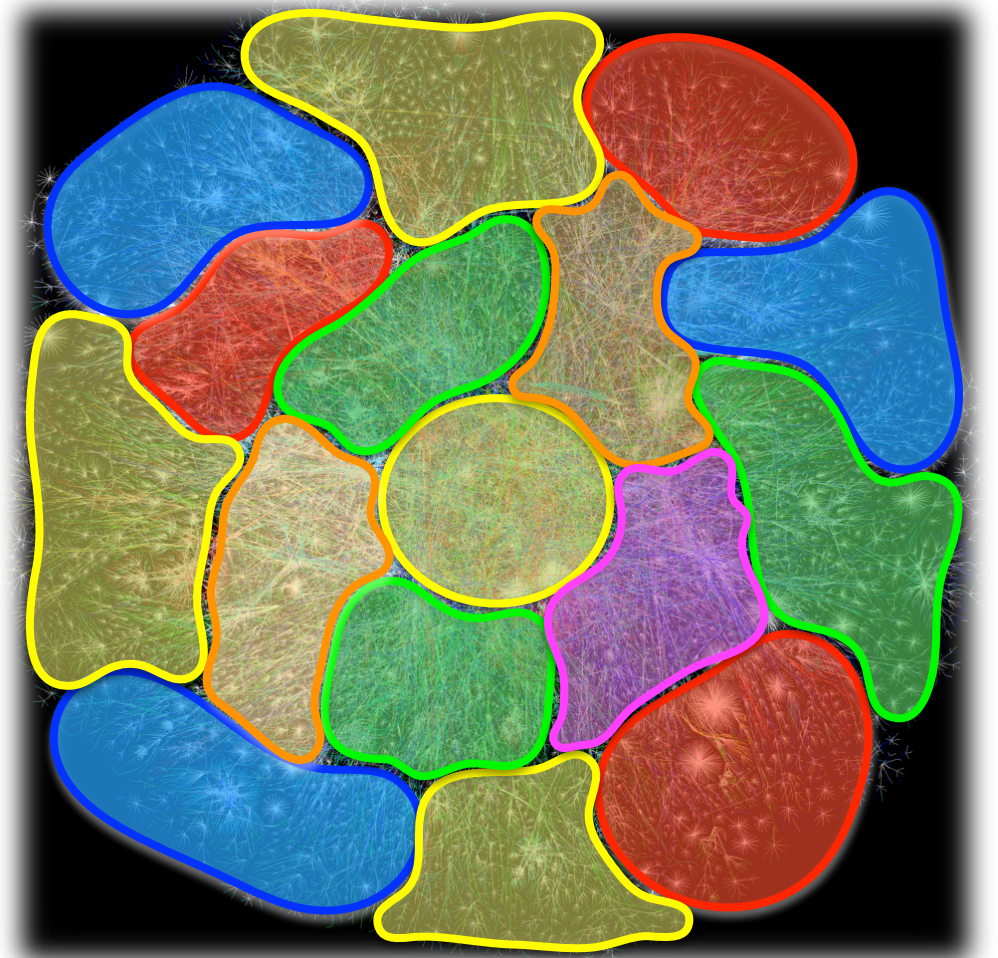
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$O(r \log^2 n)$ -round **LOCAL** alg.:  
returns *w.h.p.* the  $Y^{(\pi)}$   
for some ordering  $\pi$





# Local Exact Sampler

Uniform sampling **ind. set** in graphs with max-degree  $\Delta \leq 5$ :

- Each  $v \in V$  returns in  $O(\log^3 n)$  rounds:
  - **local output**  $Y_v \in \{0, 1\}$ ;
  - **local failure**  $F_v \in \{0, 1\}$ .
- **Succeeds w.h.p.**:  $\sum_{v \in V} \mathbf{E}[F_v] = O(1/n)$ .
- **Correctness**: conditioning on success,  $Y \sim \mu$ .

[Feng, Sun, Y., PODC'17]:

If  $\Delta \geq 6$ , there is an infinite sequence of graphs  $G$  with  $\text{diam}(G) = n^{\Omega(1)}$  such that even approx. sampling ind. set requires  $\Omega(\text{diam})$  rounds.

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Decay:**

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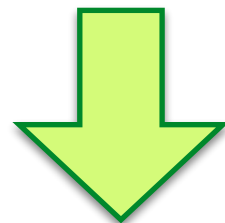
exponential  
decay

**Inference:**

$O(\log n)$ -round

local approx.  
inference

with **additive** error



local approx.  
inference

with **multiplicative** error

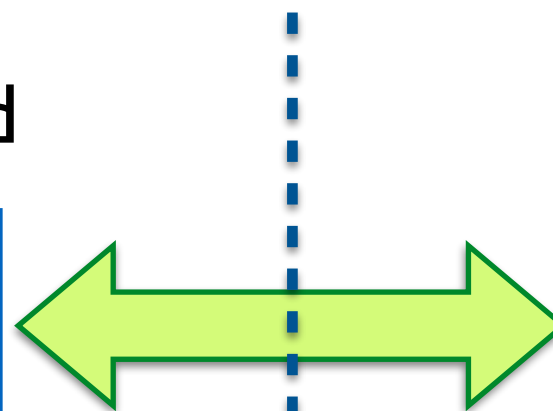
**Sampling:**

$O(\log^3 n)$ -round

local approx.  
sampling

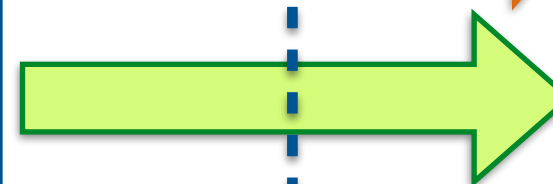


local **exact**  
sampling



easy

$O(\log^2 n)$  factor



# Counting and Sampling

RANDOM GENERATION OF COMBINATORIAL STRUCTURES  
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Mark R. JERRUM

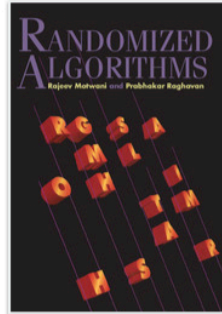
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[Jerrum-Valiant-Vazirani '86]:

(For *self-reducible* problems)

approx. counting is tractable  $\longleftrightarrow$  (approx., exact) sampling is tractable

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Sampling **almost-uniform independent set** in graphs with maximum degree  $\Delta$ :

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- [Sly, FOCS'10]: If  $\Delta \geq 6$ , no poly-time algorithm unless  $\text{NP}=\text{RP}$ .

A **phase transition** occurs when  $\Delta: 5 \rightarrow 6$ .

# Hold for Local Computation!

# Algorithmic Implications

(due to the state-of-the-arts of **strong spatial mixing**)

- $O(\sqrt{\Delta} \log^3 n)$  -round distributed algorithm for sampling matchings in graphs with max-degree  $\Delta$ ;
- $O(\log^3 n)$  -round distributed algorithms for sampling:
  - hardcore model (weighted independent set) in the **uniqueness regime**;
  - antiferromagnetic Ising model in the **uniqueness regimes**;
  - antiferromagnetic 2-spin systems in the **uniqueness regimes**;
  - weighted hypergraph matchings in the **uniqueness regimes**;
  - uniform  $q$ -coloring/list-coloring when  $q > 1.763 \dots \Delta$  in triangle-free graphs with max-degree  $\Delta$ ;
  - ... ..

Thank you!